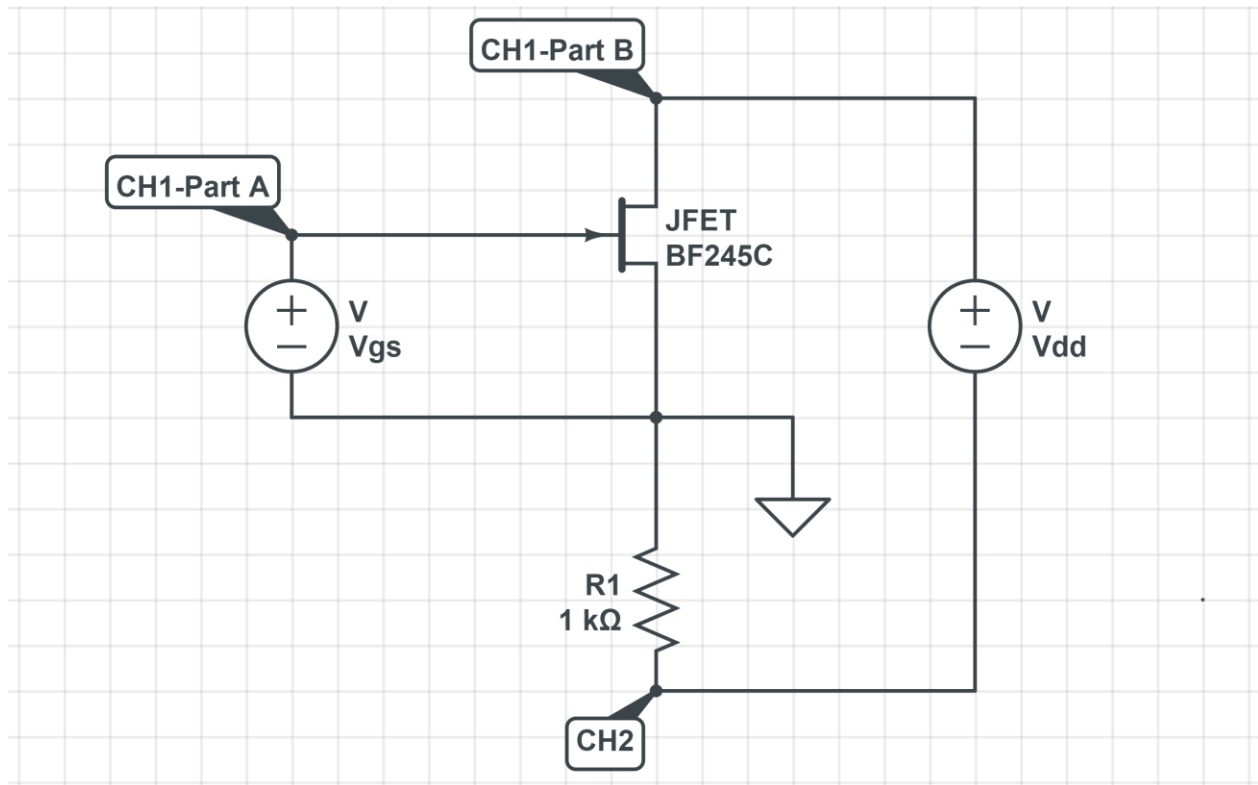


### EEE313 Lab 03

#### Junction Field Effect Transistor Static Characteristics

In this lab work we were tasked with finding the static transfer characteristics of a JFET. The JFET that I have used was BF245C. In order to observe transfer characteristics I have designed a oscilloscope circuit like this:



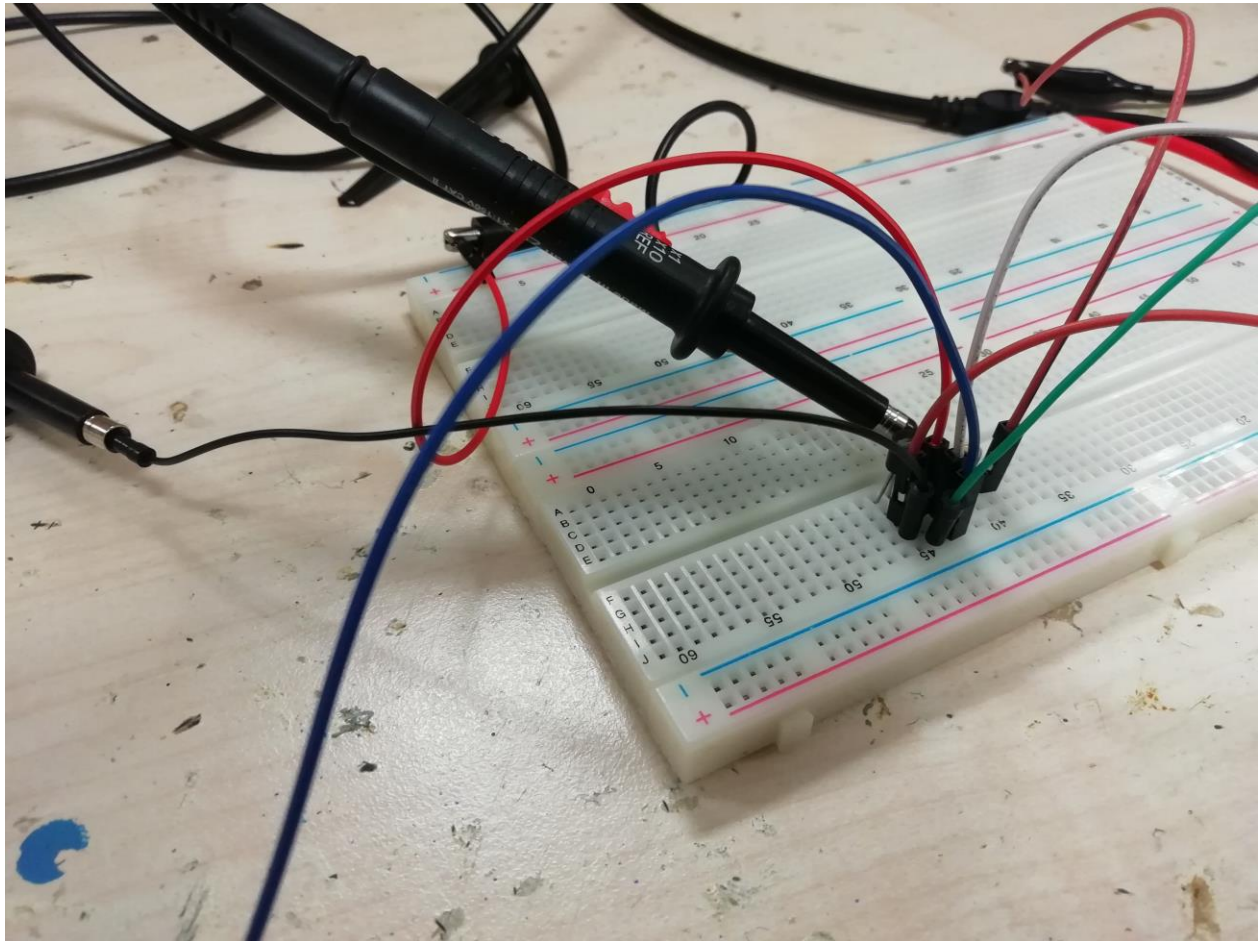
**Figure 1** (Circuit Diagram)

In Figure.1, you can see the  $V_s$  is the ground which the oscilloscope probe grounds will be connected for both Part A and Part B. CH2 is fixed for both part A and Part B and measures the Voltage across the 1k $\Omega$  source resistor which gives us the 1000 times the transistor current.

**Note:** The CH2 is connected in reverse orientation because of that I am going to invert the CH2 while plotting in the oscilloscope.

In addition, the CH1 probes will be connected to different nodes for Part A and Part B as shown in the Figure. 1.

This is the implementation of my circuit:



### Part A

For this section we need to plot  $I_D$  vs  $V_{GS}$  curve of the JFET for a  $V_{DD}$  value to keep it in SAT. I have checked the Datasheet of BF245C which the at least 2V was required to keep it in SAT condition. I have set the  $V_{DD}$  to 10V just to be safe.

**Note:** The  $V_{gs}$  value in this part is a sinusoidal wave between 0V and -5V.

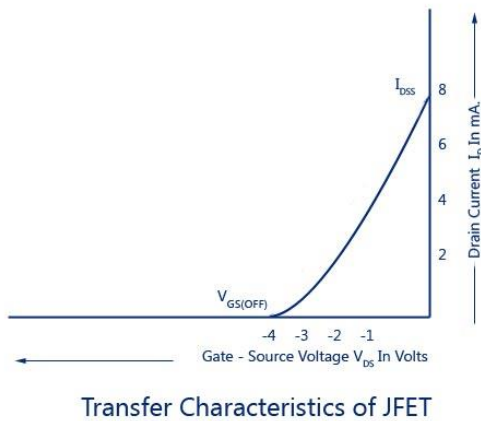


Figure 2 (The characteristic we are looking for)

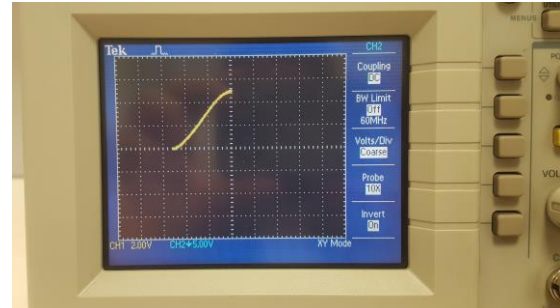


Figure 3 (Waveform that I have observed)

As we can see from the Figure 3, the plot looks very similar to characteristic JFET  $I_D$  vs.  $V_{GS}$  plot. The  $V_{GS(off)}$  appears to be around -4 and -5 range.

## Part B

In this part I have set the  $V_{GS}$  values to the different constant values and varied the  $V_{DD}$  with a sinusoidal signal between 0V and 10V. (10Vpp- 5V offset). CH1 measures the  $V_{DS}$  and CH2 is the 1000 times the transistor current.

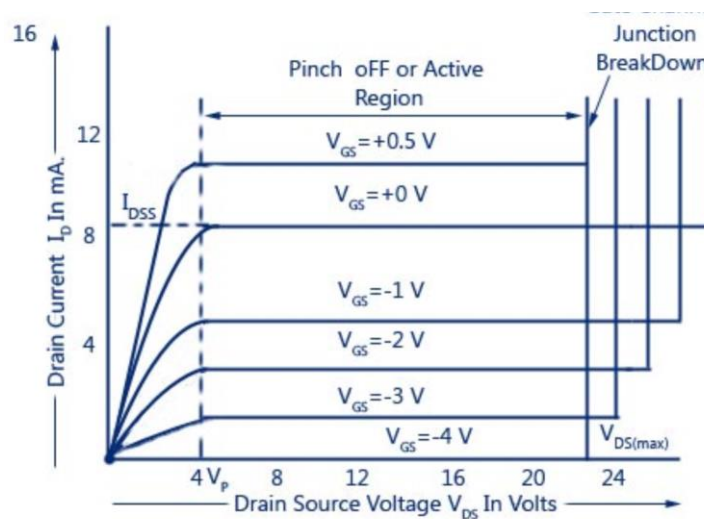


Figure 4 (Plot of a Generic JFET (this is not BF245C))

Figure 4 shows the general shape of the  $I_d$  vs.  $V_{ds}$  characteristics of a JFET. We are looking for similarly shaped plot in our measurements.

**$V_{gs} = 0$ :**

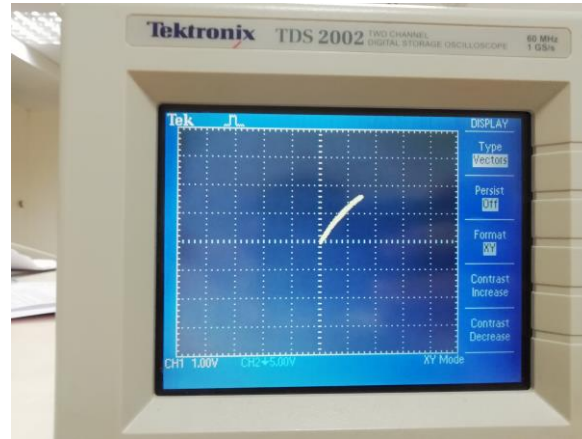


Figure 5 ( $I_d$  vs.  $V_{ds}$ )

**$V_{gs} = -1$ :**



Figure 6 ( $I_d$  vs.  $V_{ds}$ )

$V_{gs} = -2$ :

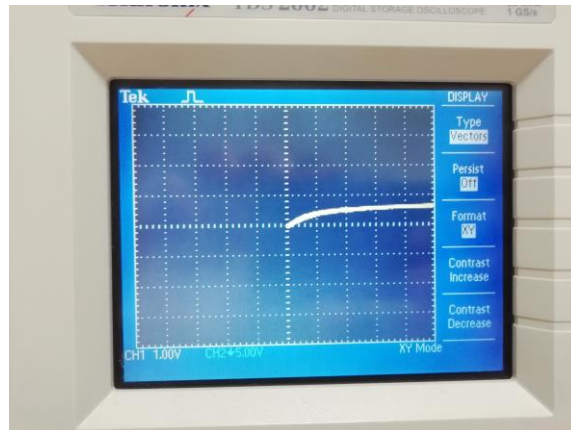


Figure 7 ( $I_d$  vs.  $V_{ds}$ )

$V_{gs} = -3$

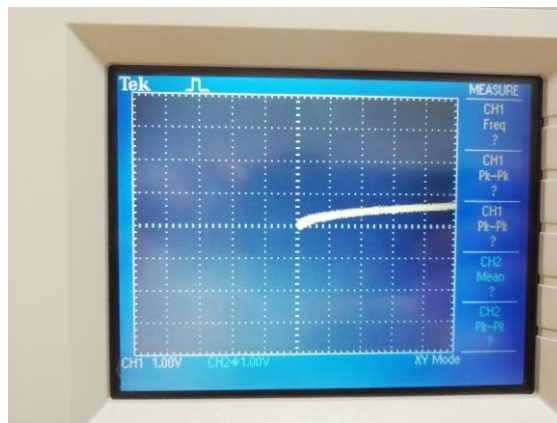


Figure 8 (The scale is different here ( $I_d$  vs.  $V_{ds}$ ))

The  $I_d$  goes to the 0mA around (-4.5V , -5V).

### Part C

$$I_D = I_{DSS} \left(1 - \frac{V_{GS}}{V_P}\right)^2 (1 + \lambda v_{DS})$$

First of all, when we set the  $V_{GS}$  to 0V, we have observed that the current was around 15mA approximately, in this case the current equals to the  $I_{DSS}$ .

Secondly, we know from the formula that when the values of  $V_{GS}$  is equal to the pinchoff voltage the current goes to zero. By looking at this knowledge and the resulting plots we can see that the pinchoff voltage is around -4V for this configuration.

Lastly, for the lambda value, we know  $I_{DSS}$  and  $V_P$  so for a fixed  $V_{GS}$  we can calculate the lambda value easily. Lambda becomes around  $3.86 \times 10^{-3}$ .

### Conclusion

I have checked the documentation of the BF245C and plots and respective values are seems to be consistent with each other. The JFET device that we are using is naturally a non-ideal device. Lambda value is not zero which results in non-zero slope beyond the saturation point. This characteristic is visible in the plots, the current slightly increases even after the saturation point.